Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination BOWMAN ET AL.	
10/527,141		
Examiner	Art Unit	
Steven J. Ganey	3752	

SEARCHED					
Class	Subclass	Date	Examiner		
239	1, 11,468 472,600 491-497 596	146/07	SS-		
216	83,100	(2/4/2	SOF		

INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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